

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

LIST OF ART CITED BY APPLICANT (PTO-1449)				ATTY. DOCKET NO. MRE-0045.01	APPLN. SERIAL NO. 10/825,361	
				APPLICANT(S) Ji Hyun HWANG, Do Hyun KIM and Sang Yeon HWANG		
				FILING DATE 4/16/2004	GROUP 1734	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
TW	4,586,670	05/06/1986	Vancelette et al.			
TW	4,620,655	11/04/1986	Fujita			
TW	4,687,152	08/18/1987	Hawkswell			
TW	5,294,035	03/15/1994	Asai et al.			
TW	5,725,140	03/10/1998	Weber et al.			
TW	6,622,379	09/23/2003	Kano			
TW	6,671,946	01/06/2004	Kadota et al.			
TW	6,748,991	06/15/2004	Hwang et al.			
U.S. PATENT APPLICATION PUBLICATIONS						
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
U.S. PATENT APPLICATIONS						
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation <input type="checkbox"/> Yes <input type="checkbox"/> No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)						
EXAMINER	DATE CONSIDERED					
/Timothy Waggoner/ (07/24/2006)						

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CORRECTED FORM PTO-1449

SHEET 1 OF 1

LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)			ATTY. DOCKET NO. MRE-0045.1	CONTINUATION OF APPLN. SERIAL NO. 09/989,461																																																																																																																																
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